Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
09/847,569	LEE ET AL.
Examiner	Art Unit
Andrew Lee	2616

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
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SEARCH NO (INCLUDING SEARCH	TES I STRATEGY	)
	DATE	EXMR
Inventor and interference search See East Search	8/5/2006	AL